Search Notes

Application/Control	No.

09/821,636 Examiner IKEDA, HIROYUKI

Applicant(s)/Patent under Reexamination

Thien F. Tran

2811

SEARCHED					
Class	Subclass	Date	Examiner		
257	59,64 66,70 72,75 365, 366	3/6/2005	π		
Above	updated	10/28/2005	π		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	- 1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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